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Space engineering - Electromagnetic compatibility

Táto norma obsahuje anglickú verziu európskej normy.  
This standard includes the English version of the European Standard.

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**Space engineering - Electromagnetic compatibility**

Ingénierie spatiale - Compatibilité électromagnétique

Raumfahrttechnik - Elektromagnetische Kompatibilität

This European Standard was approved by CEN on 29 May 2022.

CEN and CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration. Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the CEN-CENELEC Management Centre or to any CEN and CENELEC member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CEN and CENELEC member into its own language and notified to the CEN-CENELEC Management Centre has the same status as the official versions.

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**EN 16603-20-07:2022 (E)**

# Table of contents

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<b>European Foreword</b> .....	<b>7</b>
<b>Introduction</b> .....	<b>9</b>
<b>1 Scope</b> .....	<b>10</b>
<b>2 Normative references</b> .....	<b>11</b>
<b>3 Terms, definitions and abbreviated terms</b> .....	<b>12</b>
3.1 Terms from other standards.....	12
3.2 Terms specific to the present standard .....	13
3.3 Abbreviated terms.....	15
<b>4 Requirements</b> .....	<b>17</b>
4.1 General system requirements.....	17
4.2 Detailed system requirements .....	17
4.2.1 Overview.....	17
4.2.2 EMC with the launch system .....	17
4.2.3 Lightning environment.....	18
4.2.4 Spacecraft charging and effects .....	18
4.2.5 Spacecraft DC magnetic emission .....	19
4.2.6 Radiofrequency compatibility .....	19
4.2.7 Hazards of electromagnetic radiation .....	20
4.2.8 Intrasystem EMC .....	20
4.2.9 EMC with ground equipment.....	20
4.2.10 Grounding.....	21
4.2.11 Electrical bonding requirements .....	21
4.2.12 Shielding (except wires and cables) .....	23
4.2.13 Wiring (including wires and cables shielding).....	23
<b>5 Verification</b> .....	<b>25</b>
5.1 Overview .....	25
5.1.1 Introduction .....	25
5.1.2 Electromagnetic effects verification plan .....	25
5.1.3 Electromagnetic effects verification report.....	25

5.2	Test conditions .....	25
5.2.1	Measurement tolerances.....	25
5.2.2	Test site .....	26
5.2.3	Ground plane .....	28
5.2.4	Power source impedance.....	28
5.2.5	General test precautions .....	30
5.2.6	EUT test configurations.....	30
5.2.7	Operation of EUT .....	33
5.2.8	Use of measurement equipment .....	34
5.2.9	Emission testing.....	36
5.2.10	Susceptibility testing.....	37
5.2.11	Calibration of measuring equipment.....	39
5.2.12	Power bus voltage.....	40
5.2.13	Photographic data .....	40
5.3	System level .....	40
5.3.1	General.....	40
5.3.2	Safety margin demonstration for critical or EED circuits .....	40
5.3.3	EMC with the launch system .....	41
5.3.4	Lightning .....	41
5.3.5	Spacecraft and static charging .....	41
5.3.6	Spacecraft DC magnetic field emission .....	42
5.3.7	Intra–system electromagnetic compatibility .....	42
5.3.8	Radiofrequency compatibility .....	42
5.3.9	Grounding .....	42
5.3.10	Electrical bonding.....	42
5.3.11	Wiring and shielding.....	42
5.4	Equipment and subsystem level test procedures .....	43
5.4.1	Overview.....	43
5.4.2	CE, power leads, differential mode, 30 Hz to 100 kHz.....	43
5.4.3	CE, power and signal leads, 50 kHz to 100 MHz.....	45
5.4.4	CE, power leads, inrush current .....	48
5.4.5	DC Magnetic field emission, magnetic moment.....	51
5.4.6	RE, electric field, 30 MHz to 18 GHz .....	54
5.4.7	CS, power leads, 30 Hz to 100 kHz.....	58
5.4.8	CS, bulk cable injection, 50 kHz to 100 MHz.....	61
5.4.9	CS, power leads, transients .....	65
5.4.10	RS, magnetic field, 30 Hz to 100 kHz.....	69

**EN 16603-20-07:2022 (E)**

5.4.11	RS, electric field, 30 MHz to 18 GHz .....	72
5.4.12	Susceptibility to wire-coupled electrostatic discharges (legacy method).....	79
5.4.13	Susceptibility to wire-coupled electrostatic discharges (current injection probe method).....	84
5.4.14	Susceptibility to electrostatic discharges into the chassis .....	87
5.4.15	CE, power leads, time domain .....	90

**Annex A (informative) Subsystem and equipment limits..... 92**

A.1	Overview .....	92
A.2	CE on power leads, differential mode, 30 Hz to 100 MHz .....	92
A.3	CE on power leads, in-rush currents.....	94
A.4	CE on power and signal leads, common mode, 50 kHz to 100 MHz .....	94
A.5	<<deleted>> .....	95
A.6	DC magnetic field emission .....	95
A.6.1	General.....	95
A.6.2	Characterization.....	95
A.6.3	Limit.....	96
A.7	RE, low-frequency magnetic field.....	96
A.8	RE, low-frequency electric field.....	96
A.9	RE, electric field, 30 MHz to 18 GHz.....	97
A.10	CS, power leads, differential mode, 30 Hz to 100 kHz .....	97
A.11	CS, power and signal leads, common mode, 50 kHz to 100 MHz .....	98
A.12	CS, power leads, short spike transients .....	99
A.13	RS, magnetic field, 30 Hz to 100 kHz.....	100
A.14	RS, electric field, 30 MHz to 18 GHz.....	101
A.15	Susceptibility to wire-coupled electrostatic discharges (legacy method).....	102

**Figures**

Figure 4-1: Bonding requirements .....	22
Figure 5-1: RF absorber loading diagram .....	27
Figure 5-2: Line impedance stabilization network schematic .....	29
Figure 5-3: General test setup.....	31
Figure 5-4: Typical calibration fixture .....	35
Figure 5-5: Conducted emission, 30 Hz to 100 kHz, measurement system check .....	45
Figure 5-6: Conducted emission, 30 Hz to 100 kHz, measurement setup.....	45
Figure 5-7: Conducted emission, measurement system check.....	46
Figure 5-8: Conducted emission, measurement setup in differential mode .....	47

Figure 5-9: Conducted emission, measurement setup in common mode.....	47
Figure 5-10: Inrush current: measurement system check setup.....	49
Figure 5-11: Inrush current: measurement setup.....	49
Figure 5-12: Smooth deperm procedure.....	54
Figure 5-13: Electric field radiated emission. Basic test setup.....	56
Figure 5-14: Electric field radiated emission. Antenna positioning.....	56
Figure 5-15: Electric field radiated emission – Multiple antenna positions.....	57
Figure 5-16: CS, power leads, measurement system check set-up.....	59
Figure 5-17: CS, power leads, signal injection.....	60
Figure 5-18: Bulk cable injection, calibration set-up.....	64
Figure 5-19: Signal test waveform.....	64
Figure 5-20: CS, power and signal leads, bulk cable injection.....	65
Figure 5-21: CS, power leads, differential mode transients, calibration setup.....	66
Figure 5-22: CS, power leads, differential mode transients, injection setup.....	67
Figure 5-23: <<deleted>>.....	67
Figure 5-24: CS, power leads, common mode transients, calibration setup.....	67
Figure 5-25: CS, power leads, common mode transients, probe injection setup.....	68
Figure 5-26: Measurement system check configuration of the radiating system.....	70
Figure 5-27: Basic test setup.....	70
Figure 5-28: <<deleted>>.....	74
Figure 5-29: Example of electric field calibration test setup.....	75
Figure 5-30: RS Electric field – Multiple test antenna positions.....	76
Figure 5-31: <<deleted>>.....	76
Figure 5-32: Susceptibility to ESD: calibration configuration.....	81
Figure 5-33: Susceptibility to ESD: test equipment configuration.....	82
Figure 5-34: Example of compliant discharge current shape.....	83
Figure 5-35: Test setup for calibration of test waveform.....	85
Figure 5-36: Typical ESD pulse measured during calibration (3 A/div, 4 ns/div).....	86
Figure 5-37: Wire-coupled ESD test setup (current injection probe method).....	86
Figure 5-38: Discharge current verification setup.....	89
Figure 5-39: Ideal contact discharge current waveform at 8 kV.....	89
Figure 5-40: Conducted emission, power leads, time domain: measurement setup.....	91
Figure A-1 : Power leads, differential mode conducted emission limit.....	93
Figure A-2 : Common mode conducted emission limit.....	95
Figure A-3 : Radiated electric field limit.....	97
Figure A-4 : Conducted susceptibility limit, frequency domain.....	98
Figure A-5 : Calibration level at the measurement port of the calibration fixture.....	99

**EN 16603-20-07:2022 (E)**

Figure A-6 : CS, voltage spike in percentage of test bus voltage .....	100
Figure A-7 : Radiated susceptibility limit .....	101

**Tables**

Table 5-1: Absorption at normal incidence.....	27
Table 5-2: Bandwidth and measurement time .....	36
Table 5-3: Maximum step sizes for susceptibility tests.....	38
Table 5-4: Correspondence between test procedures and limits .....	43
Table A-1 : Equipment: susceptibility to conducted interference, test signal .....	99

# European Foreword

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This document (EN 16603-20-07:2022) has been prepared by Technical Committee CEN/CLC/JTC 5 "Space", the secretariat of which is held by DIN.

This standard (EN 16603-20-07:2022) originates from ECSS-E-ST-20-07C Rev.2.

This European Standard shall be given the status of a national standard, either by publication of an identical text or by endorsement, at the latest by April 2023, and conflicting national standards shall be withdrawn at the latest by April 2023.

Attention is drawn to the possibility that some of the elements of this document may be the subject of rights. CEN [and/or CENELEC] shall not be held responsible for identifying any or all such patent rights.

This document supersedes EN 16603-20-07:2014.

The main changes with respect to EN 16603-20-07:2014 are listed below:

- Implementation of Change Requests.
- Specification of the maximum frequency step size for susceptibility tests, in clause 5.2.10.1.
- Addition of clause 5.2.12 "Power bus voltage".
- Addition of clause 5.2.13 "Photographic data".
- Specification of a method for conducted susceptibility to short transients coupled on EUT power leads in both differential and common mode, in clause 5.4.9.
- Specification of the radiated susceptibility tests to electric fields to follow a substitution method, in clause 5.4.11.
- Addition of clause 5.4.13 "Susceptibility to wire-coupled electrostatic discharges (current injection probe method)".
- Addition of clause 5.4.14 "Susceptibility to electrostatic discharges into the chassis".
- Addition of clause 5.4.15 "CE, power leads, time domain".

This document has been prepared under a standardization request given to CEN by the European Commission and the European Free Trade Association.

This document has been developed to cover specifically space systems and has therefore precedence over any EN covering the same scope but with a wider domain of applicability (e.g. : aerospace).

According to the CEN-CENELEC Internal Regulations, the national standards organizations of the following countries are bound to implement this European Standard: Austria, Belgium, Bulgaria, Croatia, Cyprus, Czech Republic, Denmark, Estonia, Finland, Former Yugoslav Republic of Macedonia, France,



**EN 16603-20-07:2022 (E)**

Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, Netherlands, Norway, Poland, Portugal, Romania, Serbia, Slovakia, Slovenia, Spain, Sweden, Switzerland, Türkiye and the United Kingdom.

# Introduction

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Electromagnetic compatibility (EMC) of a space system or equipment is the ability to function satisfactorily in its electromagnetic environment without introducing intolerable electromagnetic disturbances to anything in that environment.

The space system is designed to be compatible with its external natural, induced, or man-made electromagnetic environment. Natural components are lightning for launchers, the terrestrial magnetic field for space vehicles. Spacecraft charging is defined as voltage building-up of a space vehicle or spacecraft units when immersed in plasma. Electrostatic discharges result from spacecraft charging with possible detrimental effects. External man-made interference, intentional or not, are caused by radar or telecommunication beams during ground operations and the launching sequence. Intersystem EMC also applies between the launcher and its payload or between space vehicles.

Intrasystem EMC is defined between all electrical, electronic, electromagnetic, and electromechanical equipment within the space vehicle and by the presence of its self-induced electromagnetic environment. It comprises the intentional radiated electromagnetic fields and parasitic emission from on-board equipment. Both conducted and radiated emissions are concerned. An electromagnetic interference safety margin is defined at system critical points by comparison of noise level and susceptibility at these points.

# 1

## Scope

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EMC policy and general system requirements are specified in ECSS-E-ST-20.

This ECSS-E-ST-20-07 Standard addresses detailed system requirements (Clause 4), general test conditions, verification requirements at system level, and test methods at subsystem and equipment level (Clause 5) as well as informative limits (Annex A).

Associated to this standard is ECSS-E-ST-20-06 “Spacecraft charging”, which addresses charging control and risks arising from environmental and vehicle-induced spacecraft charging when ECSS-E-ST-20-07 addresses electromagnetic effects of electrostatic discharges.

Annexes A to C of the ECSS-E-ST-20 standard document EMC activities related to ECSS-E-ST-20-07: the EMC Control Plan (Annex A) defines the approach, methods, procedures, resources, and organization, the Electromagnetic Effects Verification Plan (Annex B) defines and specifies the verification processes, analyses and tests, and the Electromagnetic Effects Verification Report (Annex C) document verification results. The EMEVP and the EMEVR are the vehicles for tailoring this standard.

This standard may be tailored for the specific characteristic and constrains of a space project in conformance with ECSS-S-ST-00-02.

## 2

## Normative references

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The following normative documents contain provisions which, through reference in this text, constitute provisions of this ECSS Standard. For dated references, subsequent amendments to, or revision of any of these publications do not apply, However, parties to agreements based on this ECSS Standard are encouraged to investigate the possibility of applying the more recent editions of the normative documents indicated below. For undated references, the latest edition of the publication referred to applies.

EN reference	Reference in text	Title
EN 16601-00-010	ECSS-S-ST-00-01	ECSS system - Glossary of terms
EN 16603-20	ECSS-E-ST-20	Space engineering - Electrical and electronic
EN 16603-20-06	ECSS-E-ST-20-06	Space engineering - Spacecraft charging
EN 16603-33-11	ECSS-E-ST-33-11	Space engineering - Explosive subsystems and devices
EN 16603-50-14	ECSS-E-ST-50-14	Space engineering – Spacecraft discrete interfaces
	IEC 61000-4-2 (Edition 1.2)	Electromagnetic compatibility (EMC) - Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test

**koniec náhľadu – text ďalej pokračuje v platenej verzii STN**